Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/980,604	ISHII ET AL.	
Examiner	Art Unit	
Hai Tran	3694	

SEARCHED					
Class	Subclass	Date	Examiner		
705	36	12/18/2007	нт		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH I (INCLUDING SEAR		 ()
	DATE	EXMR
PALM inventor search	12/17/2007	нт
EAST Tool search	12/17/2007	нт
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